

FIRE AND BLAST INFORMATION GROUP

91st TECHNICAL MEETING: LEAK FREQUENCIES: UP OR DOWN?

HALF-DAY EVENT

21st June 2017
Aberdeen University, AB24 3UE, Aberdeen



22nd June 2017
Broadway House, Tothill Street, SW1H 9NQ, London
and
via LIVE WEBCAST
(Registering for the webcast enables live viewing of the meeting)

Programme:

SESSION TITLE	TIME (UK)
Registration and lunch	12:00 - 13:00
History of the Hydrocarbon Release Database (HCRD), problems encountered and improvements made <i>D. Mansfield - ESR Technology & B. Bain - DNV GL</i>	13:00 - 13:30
HCR Database and its use in the future <i>S. Pabby - Health and Safety Executive</i>	13:30 - 14:00
New insights from compilation of high quality hydrocarbon leak database for installations on the Norwegian Continental Shelf <i>J. Wiklund - Lilleaker Consulting</i>	14:00 - 14:30
PLOFAM model - a new milestone for modelling loss of containment frequencies in QRAs <i>A. Sæbbø - Lloyd's Register</i>	14:30 - 15:00
Coffee Break	15:00 - 15:25
Analysis of the HCRD and development of leak frequency models <i>B. Bain - DNV GL</i>	15:25 - 15:55
Upgraded models for accident frequency estimation - a step change in the modelling of frequencies for leaks, fires and explosions <i>I. Fossan - ComputIT</i>	15:55 - 16:25
Implications of new leak frequency model on design and operations <i>M. Sorum - Statoil</i>	16:25 - 16:55
Meeting Close	16:55

Continuing Professional Development:

We would like to remind you that members of most engineering institutions can count FABIG Technical Meetings as Continuing Professional Development (CPD). Attendance certificates are issued to delegates upon request.

Attendance Fee:

FABIG Members: Free

Non-members: £350 (excluding VAT) per person for the Aberdeen and London events

Please note that **only FABIG Members can register for the webcasts.**

Registration:

Please register for the event online at <http://www.fabig.com/events>.

For any FABIG related information, please contact Sue Coker or Jane Burrell at SCI:

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